





Texas **INSTRUMENTS**

SN54HC377, SN74HC377 SCLS307D - JANUARY 1996 - REVISED MAY 2022

SNx4HC377 Octal D-Type Flip-Flops With Clock Enable

1 Features

- Wide operating voltage range of 2 V to 6 V
- Outputs can drive up to 10 LSTTL loads
- Low power consumption, 80-µA max I_{CC}
- Typical t_{pd} = 12 ns
- ±4-mA output drive at 5 V
- Low input current of 1 µA max
- Eight flip-flops with single-rail outputs
- Clock enable latched to avoid false clocking

2 Applications

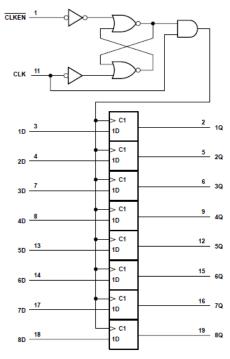
- Buffer/storage registers
- Shift registers
- Pattern generators

3 Description

These devices are positive-edge-triggered octal Dtype flip-flops with an enable input. The 'HC377 devices are similar to the 'HC273 devices, but feature a latched clock-enable (CLKEN) input instead of a common clear.

Device Information									
PART NUMBER	PACKAGE ⁽¹⁾	BODY SIZE (NOM)							
SN74HC377DW	SOIC (20)	12.80 mm × 7.50 mm							
SN74HC377N	PDIP (20)	25.40 mm × 6.35 mm							
SN74HC377NS	SO (20)	15.00 mm × 5.30 mm							
SN54HC377J	CDIP (20)	26.92 mm × 6.92 mm							
SNJ54HC377FK	LCCC (20)	8.89 mm × 8.45 mm							

For all available packages, see the orderable addendum at (1) the end of the data sheet.



Functional Block Diagram





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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

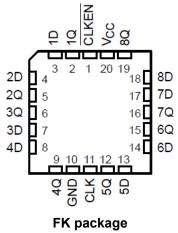
Changes from Revision C (January 2022) to Revision D (May 2022)	Page
 Junction-to-ambient thermal resistance values increased. DW was 58 is now 109.1, N v NS was 60 is now 113.4 	,
Changes from Revision B (January 2003) to Revision C (January 2022)	Page



5 Pin Configuration and Functions

	1	O_{20}	Vcc
1Q	2	19	8Q
1D [3	18	8D
2D [4	17	7D
2Q	5	16	7Q
3Q	6	15	6Q
3D	7	14	6D
4D	8	13	5D
4Q [9	12	5Q
GND [10	11	CLK

J, DW, N, or NS package 20-Pin CDIP, SOIC, PDIP, SO Top View



20-Pin LCCC Top View



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	7	V
I _{IK}	Input clamp current ⁽²⁾	$(V_1 < 0 \text{ or } V_1 > V_{CC})$		±20	mA
I _{ок}	Output clamp current ⁽²⁾	$(V_O < 0 \text{ or } V_O > V_{CC})$		±20	mA
lo	Continuous output current	$(V_{O} = 0 \text{ to } V_{CC})$		±25	mA
	Continuous current through V _C	_C or GND		±50	mA
TJ	Junction temperature			150	°C
T _{stg}	Storage temperature		-65	150	°C

(1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

6.2 Recommended Operating Conditions⁽¹⁾

			SN	154HC377		SN74HC377			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC}	Supply voltage		2	5	6	2	5	6	V
		V _{CC} = 2 V	1.5			1.5			
VIH	High-level input voltage	V _{CC} = 4.5 V	3.15			3.15			V
		V _{CC} = 6 V	4.2			4.2			1
		V _{CC} = 2 V			0.5			0.5	
VIL	Low-level input voltage	V _{CC} = 4.5 V			1.35			1.35	V
		V _{CC} = 6 V			1.8			1.8	
VI	Input voltage		0		V _{CC}	0		V_{CC}	V
Vo	Output voltage		0		V _{CC}	0		V _{CC}	V
		V _{CC} = 2 V			1000			1000	
tt	Input transition rise/fall time	V _{CC} = 4.5 V			500			500	ns
		V _{CC} = 6 V			400			400	1
T _A	Operating free-air temperature		- 55		125	- 40		85	°C

 All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report Implications of Slow or Floating SMOS Inputs, literature number SCBA004.

6.3 Thermal Information

		DW (SOIC)	N (PDIP)	NS (SO)	
THERMAL METRIC		20 PINS	20 PINS	20 PINS	UNIT
R _{θJA}	Junction-to-ambient thermal resistance ⁽¹⁾	109.1	84.6	113.4	°C/W
R _{0JC(top)}	Junction-to-case (top) thermal resistance	76	72.5	78.6	°C/W
R _{θJB}	Junction-to-board thermal resistance	77.6	65.3	78.4	°C/W
Ψ _{JT}	Junction-to-top characterization parameter	51.5	55.3	47.1	°C/W
Ψјв	Junction-to-top characterization parameter	77.1	65.2	78.1	°C/W



6.3 Thermal Information (continued)

		DW (SOIC)	N (PDIP)	NS (SO)	
THERMAL MET	RIC	20 PINS	20 PINS	20 PINS	UNIT
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC package thermal metrics application report.

6.4 Electrical Characteristics

PARAMETER	TEST CONDITIONS ⁽¹⁾		T,	_A = 25°C		SN74HC	377	SN74HC	377	UNIT
PARAMETER	TEST CONDITIONS(*)	V _{CC} (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
		2	1.9	1.998		1.9		1.9		
	I _{OH} = –20 μA	4.5	4.4	4.499		4.4		4.4		
V _{OH}		6	5.9	5.999		5.9		5.9		V
	I _{OH} =4 mA	4.5	3.98	4.3		3.7		3.84		
	I _{OH} = – 5.2 mA	6	5.48	5.8		5.2		5.34		
		2		0.002	0.1		0.1		0.1	
	I _{OL} = 20 μA	4.5		0.001	0.1		0.1		0.1	
V _{OL}		6		0.001	0.1		0.1		0.1	V
	I _{OL} = 4 mA	4.5		0.17	0.26		0.4		0.33	
	I _{OL} = 5.2 mA	6		0.15	0.26		0.4		0.33	
I _I	$V_{I} = V_{CC} \text{ or } 0$	6		±0.1	±100		±1000		±1000	nA
I _{CC}	$V_{I} = V_{CC} \text{ or } 0. I_{O} = 0$	6			8		160		80	μA
Ci		2 to 6		3	10		10		10	pF

(1) $V_I = V_{IH}$ or V_{IL} , unless otherwise noted.

6.5 Timing Requirements

			v	T _A = 2	5°C	SN54H	C377	SN74H	C377	UNIT
			V _{cc}	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
			2		5		3		4	
f _{clock}	Clock frequency		4.5		25		16		20	MHz
			6		29		19		23	
			2	100		150		125		
t _W	Pulse duration, CLK high or	low	4.5	20		30		25		ns
			6	17		25		21		
		D	2	100		150		125		
			4.5	20		30		25		
+	Setup time, data before		6	17		25		21		ns
t _{su}	CLK↑		2	100		150		125		115
		CLKEN high or low	4.5	20		30		25		
			6	17		25		21		
			2	5		5		5		
t _h	Hold time, data after LE \uparrow	er LE↑ CLKEN inactive or active,	4.5	5		5		5		ns
			6	5		5		5		



6.6 Switching Characteristics

over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) See Parameter Measurement Information

PARAM	FROM (INPUT)	TO (OUTPUT)	V _{cc} (V)	Τ,	₄ = 25°C		SN54HC	377	SN74HC	377	UNIT
ETER		10 (001201)	VCC (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			2	5	11		3		4		
f _{max}			4.5	25	54		16		20		MHz
			6	29	64		19		23		
			2		56	160		240		200	
t _{pd}	CLK	Any	4.5		15	32		48		40	ns
			6		12	27		41		34	
			2		38	75		110		95	
t _t		Any	4.5		8	15		22		19	ns
			6		6	13		19		16	

6.7 Operating Characteristics

T_A = 25°C

		Test Conditions	TYP	UNIT
C _{pd}	Power dissipation capacitance per flip-flop	No load	30	pF

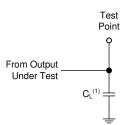


7 Parameter Measurement Information

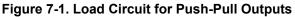
Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_t < 2.5 ns.

For clock inputs, f_{max} is measured when the input duty cycle is 50%.

The outputs are measured one at a time with one input transition per measurement.



(1) C_L includes probe and test-fixture capacitance.



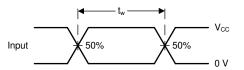


Figure 7-2. Voltage Waveforms, Standard CMOS Inputs Pulse Duration

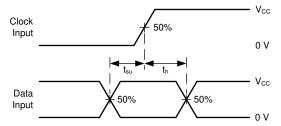
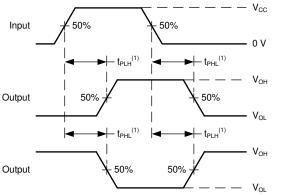


Figure 7-3. Voltage Waveforms, Standard CMOS Inputs Setup and Hold Times



 (1) The greater between t_{PLH} and t_{PHL} is the same as t_{pd}.
 Figure 7-4. Voltage Waveforms, Propagation Delays for Standard CMOS Inputs

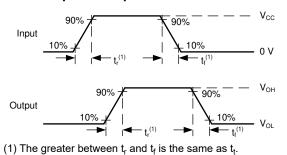


Figure 7-5. Voltage Waveforms, Input and Output Transition Times for Standard CMOS Inputs



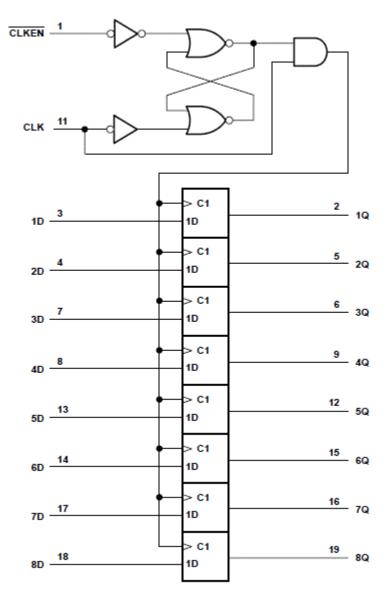
8 Detailed Description

8.1 Overview

These devices are positive-edge-triggered octal D-type flip-flops with an enable input. The 'HC377 devices are similar to the 'HC273 devices, but feature a latched clock-enable (CLKEN) input instead of a common clear.

Information at the data (D) inputs meeting the setup time requirements is transferred to the Q outputs on the positive-going edge of the clock (CLK) pulse, if \overline{CLKEN} is low. Clock triggering occurs at a particular voltage level and is not directly related to the transition time of the positive-going pulse. When CLK is at either the high or low level, the D input has no effect at the output. These devices are designed to prevent false clocking by transitions at \overline{CLKEN} .

8.2 Functional Block Diagram



8.3 Device Functional Modes

Funct	tion	Table
(Each	Flip	-Flop)

	INPUTS	3	OUTPUT						
CLKEN	CLK	D	Q						
Н	Х	Х	Q ₀						
L	1	Н	н						
L	1	L	L						
Х	L	Х	Q ₀						



9 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. A 0.1- μ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. The 0.1- μ F and 1- μ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

10 Layout

10.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices inputs must not ever be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or V_{CC} , whichever makes more sense for the logic function or is more convenient.



11 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

11.1 Documentation Support

11.1.1 Related Documentation

11.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

11.3 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

11.4 Trademarks

TI E2E[™] is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

11.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.6 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
5962-87807012A	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 87807012A SNJ54HC 377FK
5962-8780701RA	Active	Production	CDIP (J) 20	20 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8780701RA SNJ54HC377J
SN54HC377J	Active	Production	CDIP (J) 20	20 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	SN54HC377J
SN54HC377J.A	Active	Production	CDIP (J) 20	20 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	SN54HC377J
SN74HC377DW	Obsolete	Production	SOIC (DW) 20	-	-	Call TI	Call TI	-40 to 85	HC377
SN74HC377DWR	Active	Production	SOIC (DW) 20	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC377
SN74HC377DWR.A	Active	Production	SOIC (DW) 20	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC377
SN74HC377N	Active	Production	PDIP (N) 20	20 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	SN74HC377N
SN74HC377N.A	Active	Production	PDIP (N) 20	20 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	SN74HC377N
SN74HC377N.B	Active	Production	PDIP (N) 20	20 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	SN74HC377N
SN74HC377NE4	Active	Production	PDIP (N) 20	20 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	SN74HC377N
SN74HC377NSR	Active	Production	SOP (NS) 20	2000 LARGE T&R	Yes	NIPDAU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC377
SN74HC377NSR.A	Active	Production	SOP (NS) 20	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC377
SNJ54HC377FK	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 87807012A SNJ54HC 377FK
SNJ54HC377FK.A	Active	Production	LCCC (FK) 20	55 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962- 87807012A SNJ54HC 377FK
SNJ54HC377J	Active	Production	CDIP (J) 20	20 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8780701RA SNJ54HC377J
SNJ54HC377J.A	Active	Production	CDIP (J) 20	20 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8780701RA SNJ54HC377J

⁽¹⁾ **Status:** For more details on status, see our product life cycle.



PACKAGE OPTION ADDENDUM

1-Aug-2025

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN54HC377, SN74HC377 :

- Catalog : SN74HC377
- Military : SN54HC377
- NOTE: Qualified Version Definitions:
 - Catalog TI's standard catalog product
 - Military QML certified for Military and Defense Applications



Texas

STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	-	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74HC377DWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
SN74HC377NSR	SOP	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1



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PACKAGE MATERIALS INFORMATION

25-Jul-2025



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74HC377DWR	SOIC	DW	20	2000	356.0	356.0	45.0
SN74HC377NSR	SOP	NS	20	2000	356.0	356.0	45.0

TEXAS INSTRUMENTS

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25-Jul-2025

TUBE



- B - Alignment groove width

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
5962-87807012A	FK	LCCC	20	55	506.98	12.06	2030	NA
SN74HC377N	N	PDIP	20	20	506	13.97	11230	4.32
SN74HC377N.A	N	PDIP	20	20	506	13.97	11230	4.32
SN74HC377N.B	N	PDIP	20	20	506	13.97	11230	4.32
SN74HC377NE4	N	PDIP	20	20	506	13.97	11230	4.32
SNJ54HC377FK	FK	LCCC	20	55	506.98	12.06	2030	NA
SNJ54HC377FK.A	FK	LCCC	20	55	506.98	12.06	2030	NA

MECHANICAL DATA

PLASTIC SMALL-OUTLINE PACKAGE

0,51 0,35 ⊕0,25⊛ 1,27 8 14 0,15 NOM 5,60 8,20 5,00 7,40 \bigcirc Gage Plane ₽ 0,25 7 1 1,05 0,55 0°-10° Δ 0,15 0,05 Seating Plane — 2,00 MAX 0,10PINS ** 14 16 20 24 DIM 10,50 10,50 12,90 15,30 A MAX A MIN 9,90 9,90 12,30 14,70 4040062/C 03/03

NOTES: A. All linear dimensions are in millimeters.

NS (R-PDSO-G**)

14-PINS SHOWN

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



J (R-GDIP-T**) 14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

FK 20

8.89 x 8.89, 1.27 mm pitch

GENERIC PACKAGE VIEW

LCCC - 2.03 mm max height

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



DW0020A



PACKAGE OUTLINE

SOIC - 2.65 mm max height

SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



DW0020A

EXAMPLE BOARD LAYOUT

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



DW0020A

EXAMPLE STENCIL DESIGN

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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